

OTA TEST REPORT

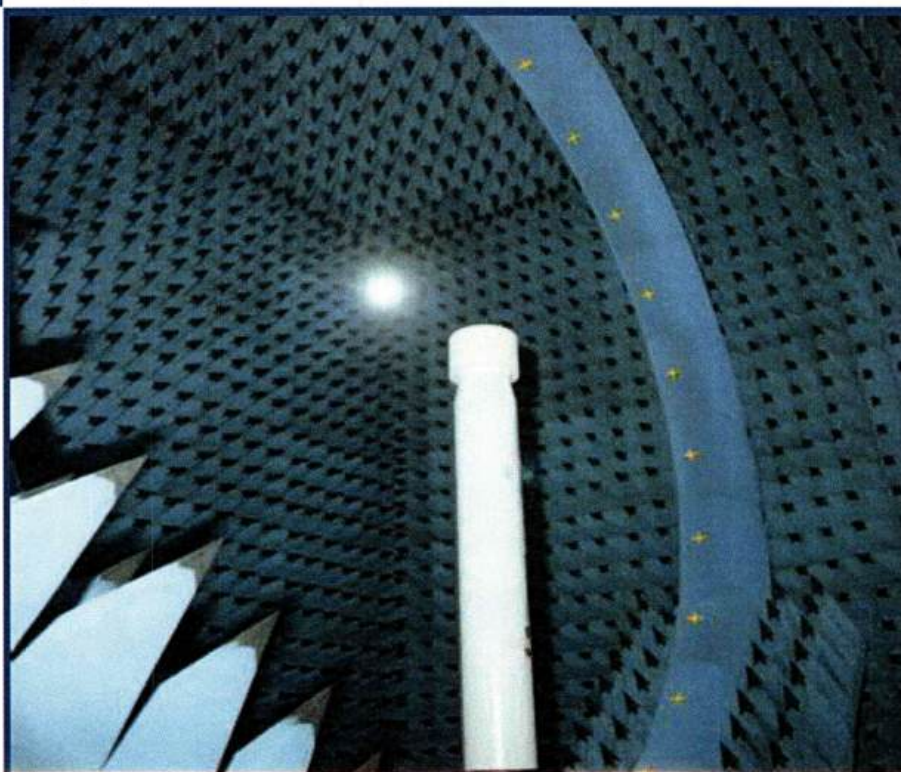
ISSUED BY
Shenzhen BALUN Technology Co., Ltd.



FOR
SwitchBot LED Strip Light

ISSUED TO
Woan Technology (Shenzhen) Co., Ltd.

Room 1101, Qiancheng Commercial Center, No. 5 Haicheng Road,
Mabu Community, Xixiang Sub-district, Bao'an District, Shenzhen,
Guangdong, P.R. China, 518100



Tested by: Zong Liyao
Zong Liyao

Date: Sep 26, 2021

Approved by: Wei Yanquan
Wei Yanquan
(Chief Engineer)

Date: Sep 26, 2021

Report No: BL-SZ2190534-901

EUT Name: SwitchBot LED Strip Light

Model Name: W1701100

Brand Name: SwitchBot

Test Standard: ANSI/IEEE Std 149-1979

Maximum: Gain: 4.28 (dBi)

Efficiency: 49%

Test Date: Sep. 17, 2021

Date of Issue: Sep. 26, 2021

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Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>Sep. 26, 2021</u>	<u>Initial Issue</u>

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1 Administrative Data (GENERAL INFORMATION)

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Description	All measurement facilities used to collect the measurement data are located at Block B, FL 1, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China 518055

1.3 Laboratory Condition

Ambient Temperature	19°C to 25°C
Ambient Relative Humidity	45% to 55%
Ambient Pressure	100 kPa to 102 kPa

1.4 Announce

- (1) The test report reference to the report template version v2.2.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
- (7) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Woan Technology (Shenzhen) Co., Ltd.
Address	Room 1101, Qiancheng Commercial Center, No. 5 Haicheng Road, Mabu Community, Xixiang Sub-district, Bao'an District, Shenzhen, Guangdong, P.R. China, 518100
Contact Person	Anna
Telephone Number	15302623345
E-mail Address	Anna.jiang@eu-test.com

2.2 Manufacturer Information

Manufacturer	Woan Technology (Shenzhen) Co., Ltd.
Address	Room 1101, Qiancheng Commercial Center, No. 5 Haicheng Road, Mabu Community, Xixiang Sub-district, Bao'an District, Shenzhen, Guangdong, P.R. China, 518100

2.3 Factory Information

Factory	N/A
Address	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Name	SwitchBot LED Strip Light
Model Name Under Test	W1701100
Antenna Type	PCB Antenna
Dimensions	25mm * 7mm

2.5 Ancillary Equipment

Note: Not applicable.

2.6 Technical Information

Frequency Range	2400MHz ~ 2483.5MHz
Test Frequencies	2400MHz, 2410MHz, 2420MHz, 2430MHz, 2440MHz, 2450MHz, 2460MHz, 2470MHz, 2480MHz, 2483.5MHz

3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	ANSI/IEEE Std 149-1979	IEEE Standard Test Procedures for Antennas

3.2 Test Verdict

Report Section	Description	Remark
ANNEX A.1	Gain and Efficiency	--
ANNEX B	Radiation Pattern	--

3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Item	Uncertainty
VSWR(S11)	± 0.61
Gain	$\pm 1.92\text{dB}$

4 GENERAL TEST CONFIGURATIONS

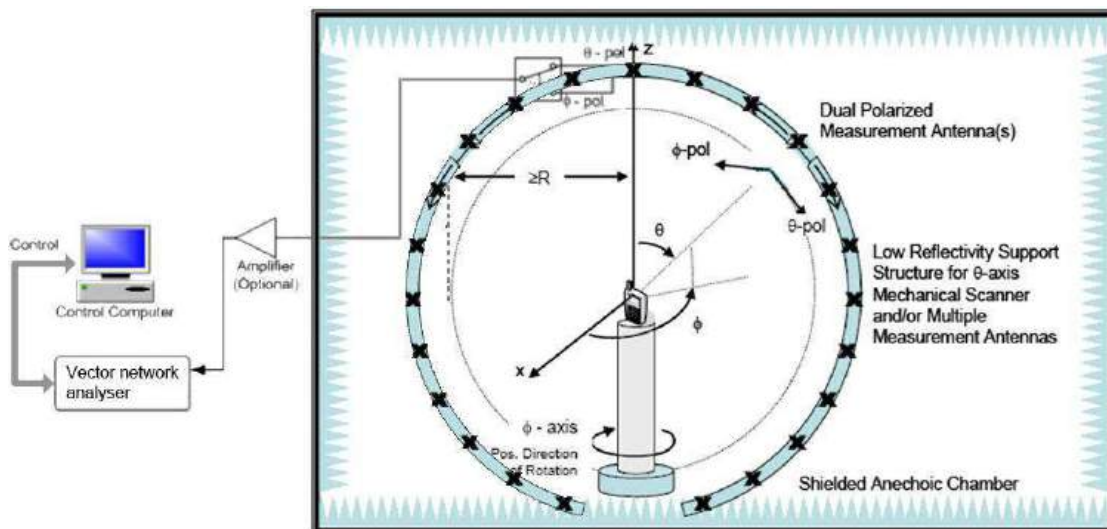
4.1 Test Condition

Environment Parameter	Selected Values During Tests			
	Ambient Pressure(KPa)	Temperature(°C)	Voltage	Relative Humidity (%)
Normal Temperature, Normal Voltage (NTNV)	100 to 102	19 to 25	N/A	45 to 55

4.2 Test Equipment List

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Vector Network Analyzer	Agilent	E5071C	MY46103472	2021.01.27	2022.01.26
SG24 Multi-probe Antenna Measurement System	SATIMO	SG24-L	1101855-0001	2021.05.23	2022.05.24

4.3 Test Setup



ANNEX A TEST RESULTS

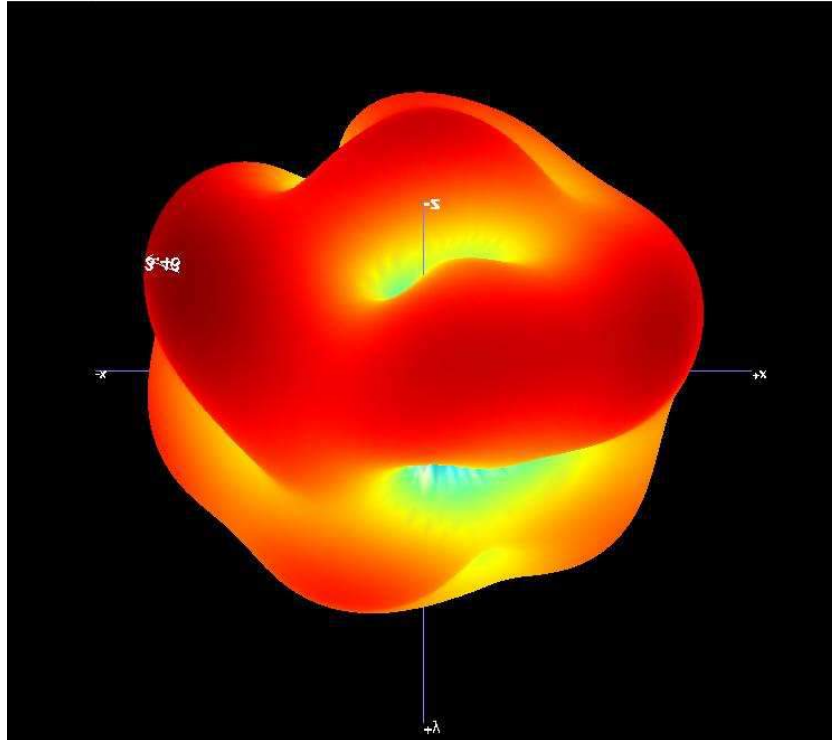
A.1 Gain and Efficiency

Frequency	Gain (dBi)	Efficiency (%)
2400MHz	3.46	44
2410MHz	3.60	44
2420MHz	3.72	45
2430MHz	3.83	45
2440MHz	3.96	46
2450MHz	3.99	46
2460MHz	4.02	46
2470MHz	4.19	48
2480MHz	4.27	49
2483.5MHz	4.28	49

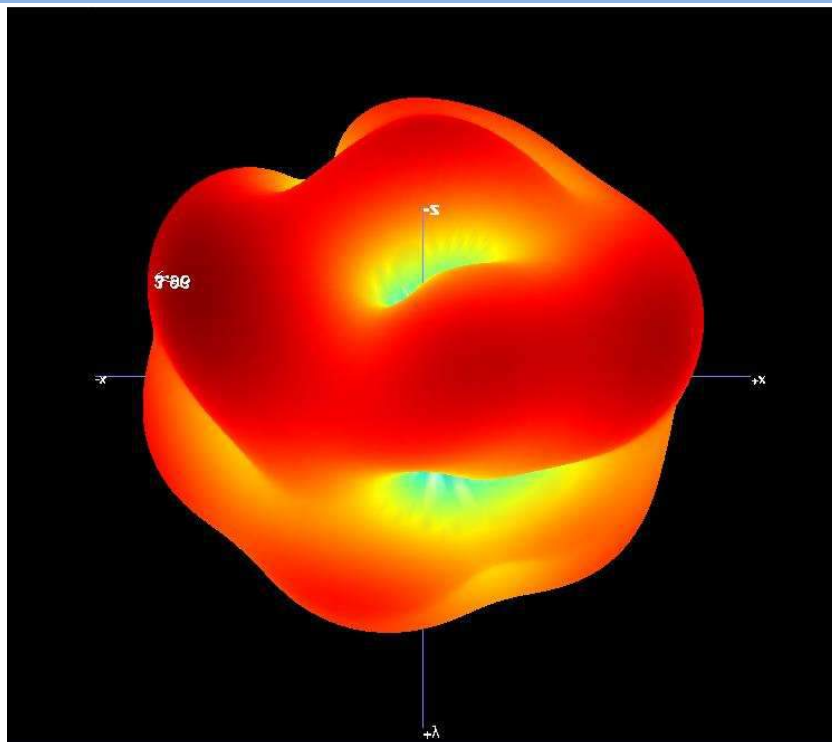
ANNEX B RADIATION PATTERN

B.1 3D Pattern

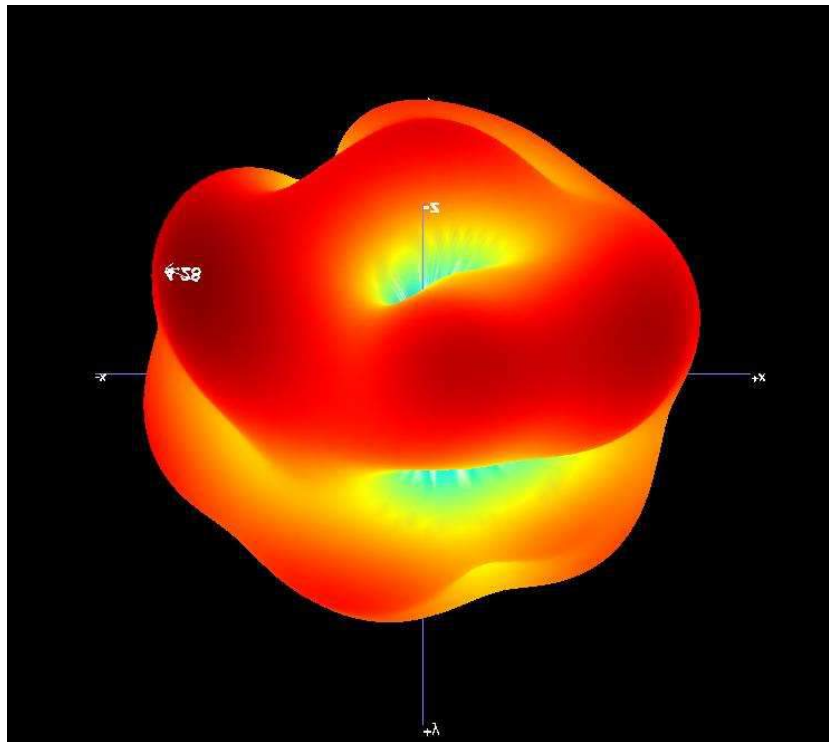
B1.1 3D Pattern for 2400MHz



B1.2 3D Pattern for 2440MHz

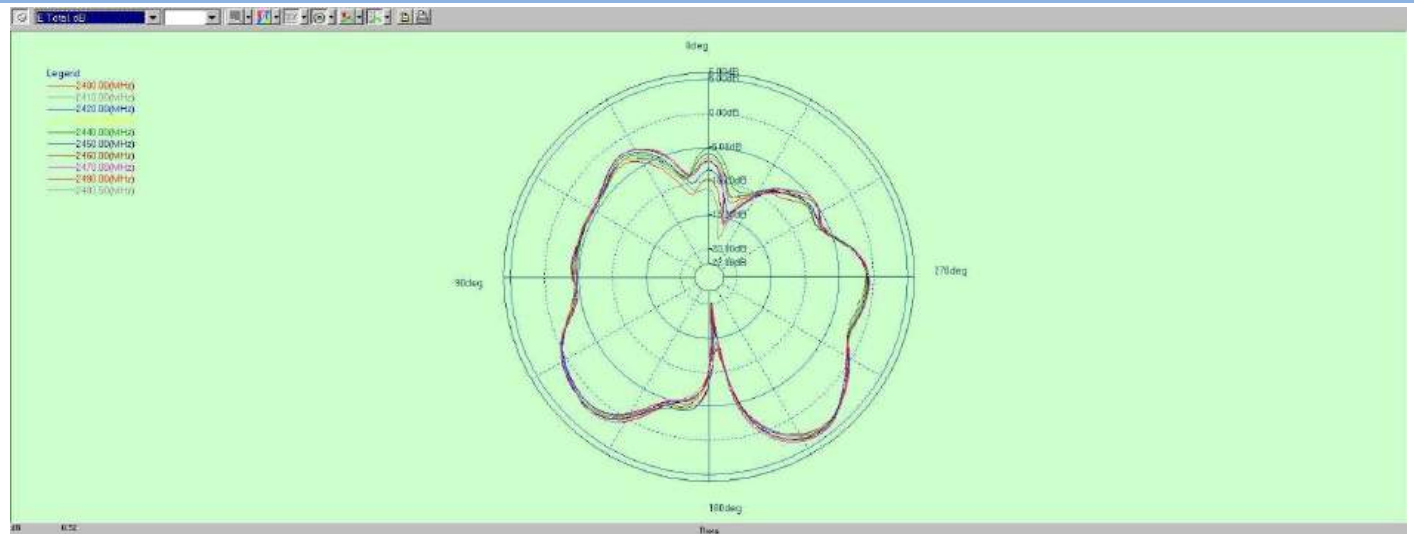


B1.3 3D Pattern for 2483.5MHz

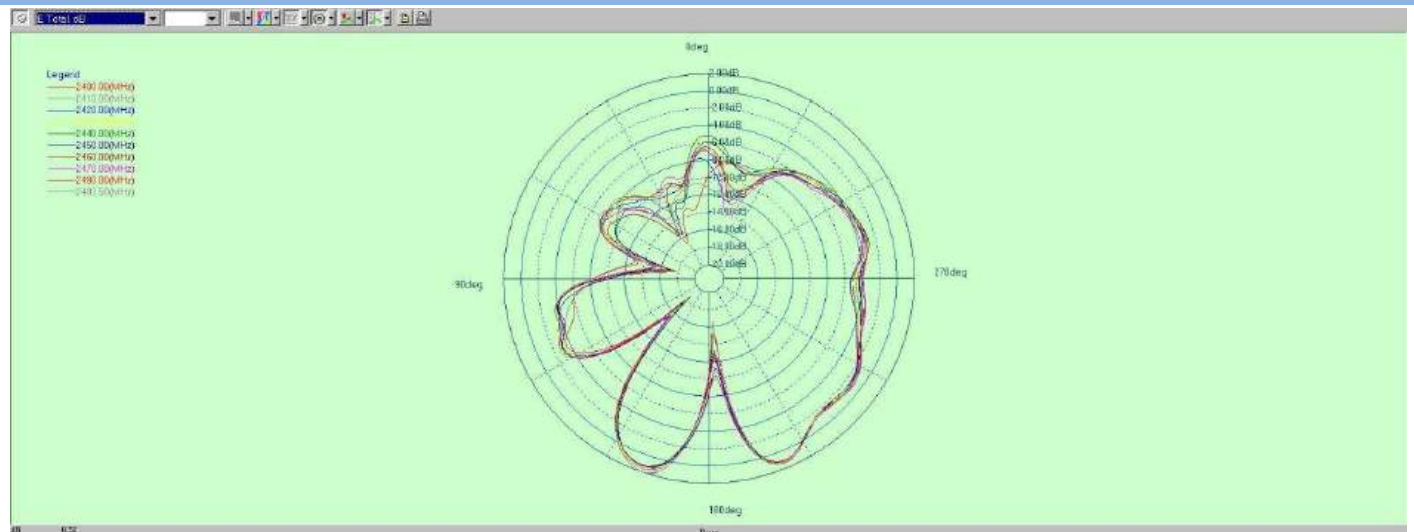


B.2 1D Radiation Pattern

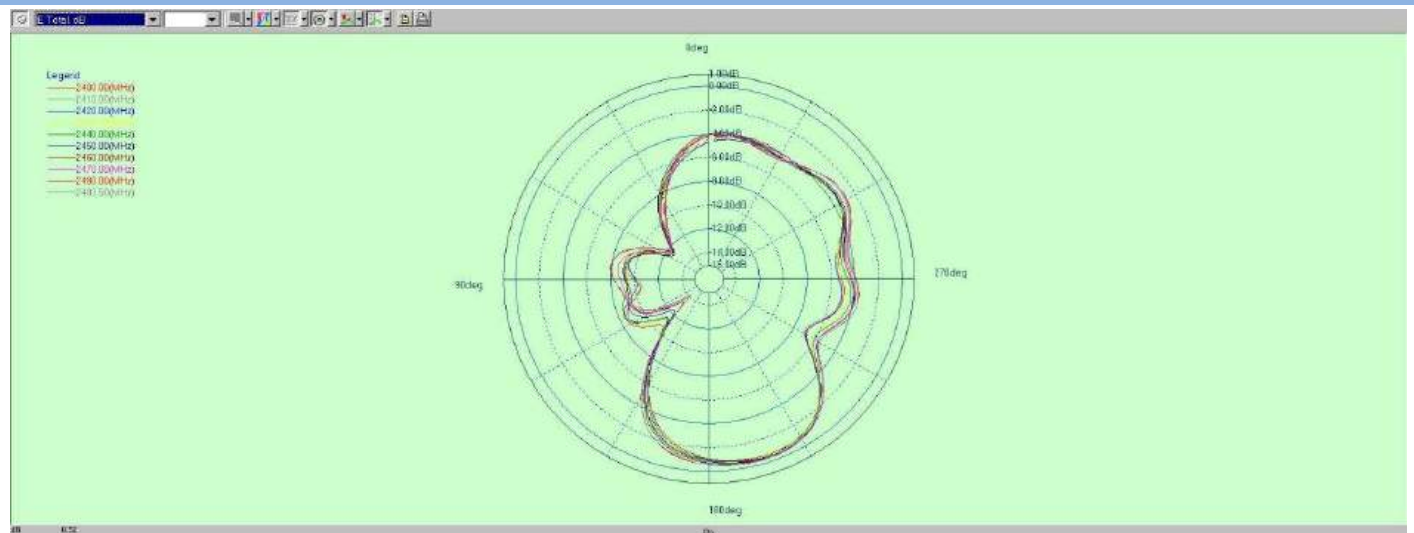
B2.1 PHI=0



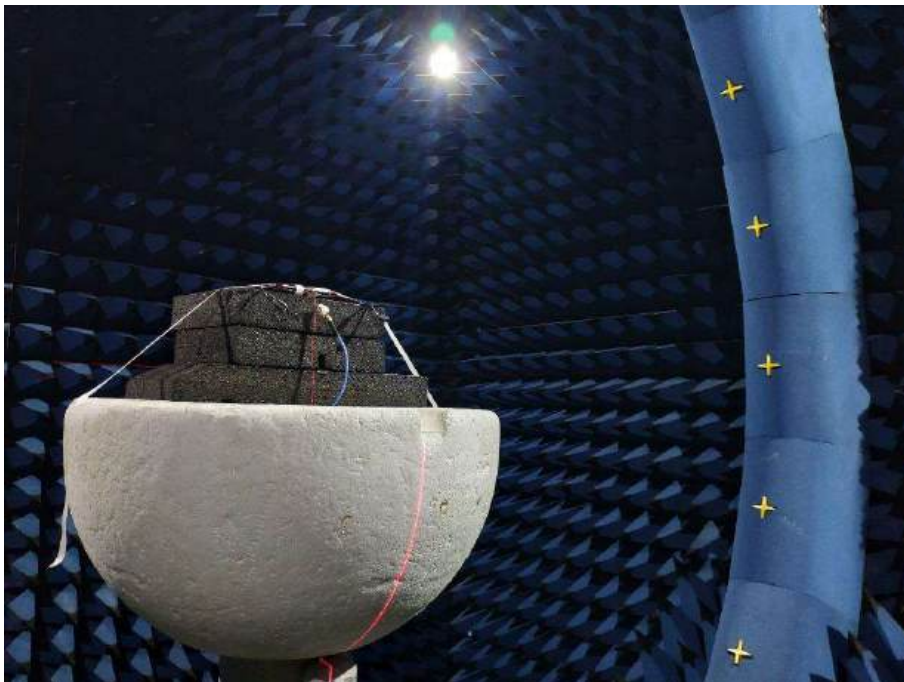
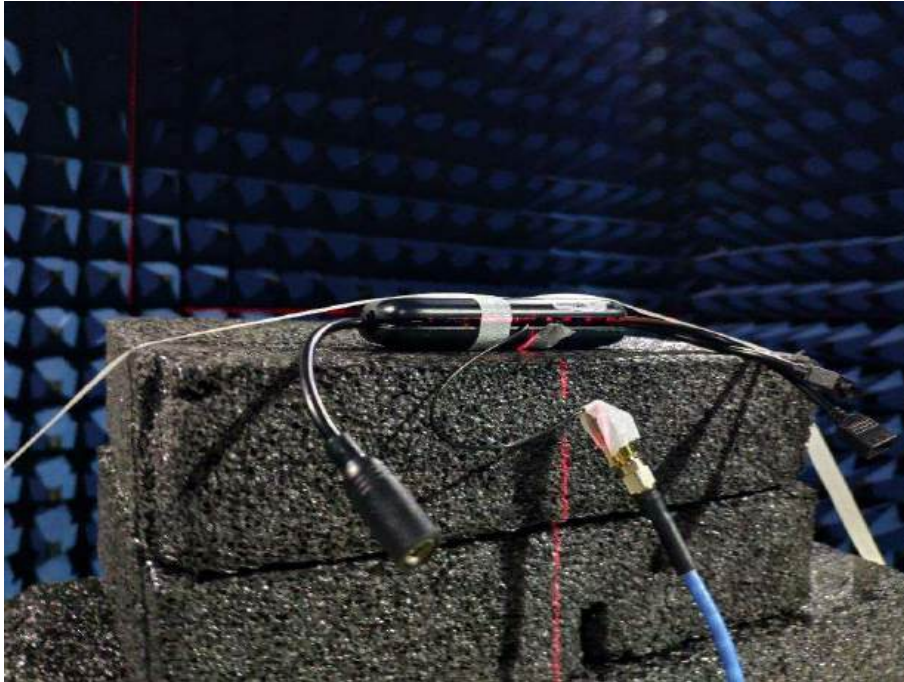
B2.2 PHI=90



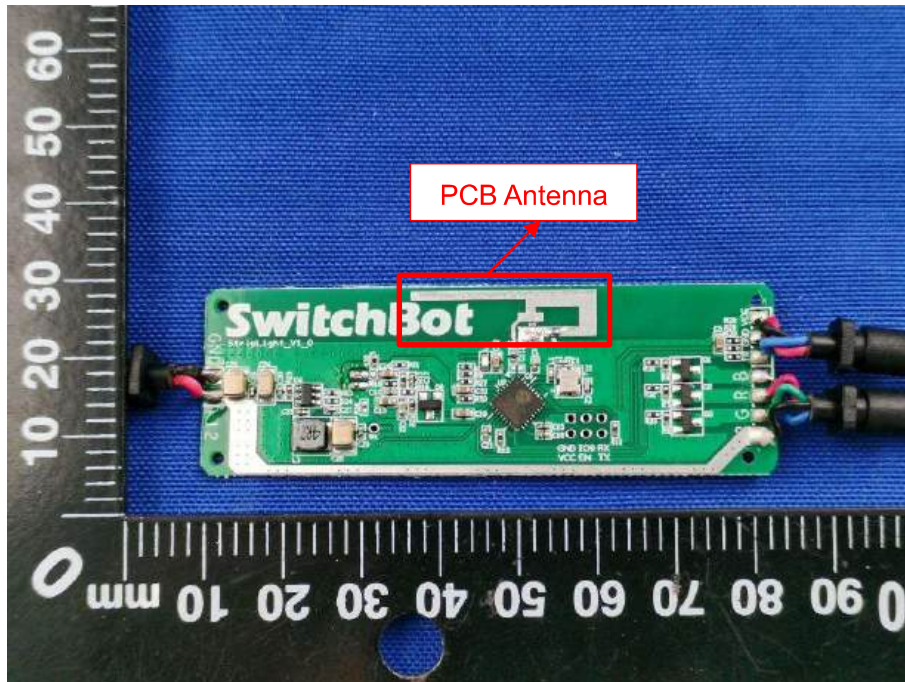
B2.3 THETA=90



ANNEX C TEST SETUP PHOTO



ANNEX D EUT PHOTO



--END OF REPORT--

